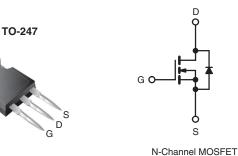
Vishay Siliconix



Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	400					
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.20				
Q _g (Max.) (nC)	210					
Q _{gs} (nC)	30					
Q _{gd} (nC)	110					
Configuration	Single					



FEATURES

- · Dynamic dV/dt Rated
- · Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP360PbF
	SiHFP360-E3
SnPb	IRFP360
	SiHFP360

S

PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage			V _{DS}	400	- V		
Gate-Source Voltage			V _{GS}	± 20			
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 \degree C$ $T_C = 100 \degree C$		1-	23			
	VGS at 10 V	$T_C = 100 ^{\circ}C$	I _D	14	А		
Pulsed Drain Current ^a			I _{DM}	92	1		
Linear Derating Factor				2.2	W/°C		
Single Pulse Avalanche Energy ^b			E _{AS}	1200	mJ		
Repetitive Avalanche Current ^a			l _{AR} 23		А		
Repetitive Avalanche Energy ^a			E _{AR}	28	mJ		
Maximum Power Dissipation	T _C =	25 °C	PD	280	W		
Peak Diode Recovery dV/dt ^c			dV/dt	4.0	V/ns		
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d			
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in		
			_	1.1	N ⋅ m		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 4.0 mH, $R_G = 25 \Omega$, $I_{AS} = 23 \text{ A}$ (see fig. 12).

c. $I_{SD} \le 23$ A, $dI/dt \le 170$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



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THERMAL RESISTANCE RAT	TINGS								
PARAMETER	SYMBOL	TYP.		MAX.		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 40 0.24 -							
Case-to-Sink, Flat, Greased Surface	R _{thCS}				°C/W				
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.45				1			
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless other	wise noted							
PARAMETER	SYMBOL	TEST C	ONDITIO	NS	MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V	V, I _D = 250) μΑ	400	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to	o 25 °C, I _D	= 1 mA	-	0.56	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_G$	_{iS} , I _D = 250	Ο μΑ	2.0	-	4.0	V	
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V			-	-	± 100	nA	
Zava Cata Valtaga Drain Current	-	$\label{eq:VDS} \begin{array}{c} V_{DS} = 400 \mbox{ V}, \mbox{ V}_{GS} = 0 \mbox{ V} \\ \hline V_{DS} = 320 \mbox{ V}, \mbox{ V}_{GS} = 0 \mbox{ V}, \mbox{ T}_{J} = 125 ^{\circ}\mbox{C} \end{array}$		-	-	25	μΑ		
Zero Gate Voltage Drain Current	I _{DSS}			-	-	250			
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D =	= 14 A ^b	-	-	0.20	Ω	
Forward Transconductance	g _{fs}	$V_{DS} = 50 \text{ V}, \text{ I}_{D} = 14 \text{ A}^{b}$		14	-	-	S		
Dynamic									
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5		-	4500	-	pF		
Output Capacitance	C _{oss}			-	1100	-			
Reverse Transfer Capacitance	C _{rss}			-	490	-			
Total Gate Charge	Qg				-	-	210		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 V$ $I_D = 23 A, V_{DS}$		-	-	30	nC	
Gate-Drain Charge	Q _{gd}	see fig. 6 and 13 ^b		-	-	110			
Turn-On Delay Time	t _{d(on)}				-	18	-		
Rise Time	t _r				-	79	-		
Turn-Off Delay Time	t _{d(off)}	$\label{eq:VDD} \begin{array}{l} V_{DD} = 200 \; V, \; I_D = 23 \; A \; , \\ R_G = 4.3 \; \Omega, \; R_D = 8.3 \; \Omega, \; \text{see fig. 10}^b \end{array}$		-	100	-	ns		
Fall Time	t _f			-	67	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	nH		
Internal Source Inductance	Ls			-	13	-			
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	23	A		
Pulsed Diode Forward Current ^a	I _{SM}			-	-	92			
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^\circ C, \ I_S = 23 \ A, \ V_{GS} = 0 \ V^b$			-	-	1.8	V	
Body Diode Reverse Recovery Time	t _{rr}	- $T_J = 25 \text{ °C}, I_F = 23 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	420	630	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	5.6	8.4	μC		
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-			-on is dor	ominated by L_S and L_D)			

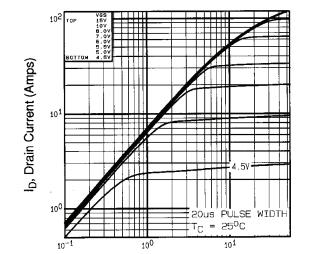
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.

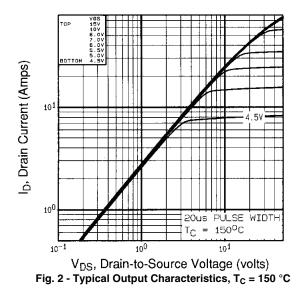


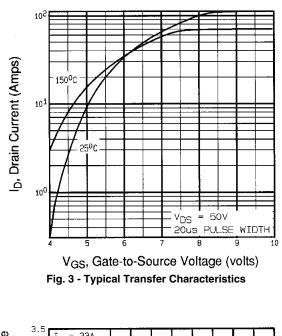
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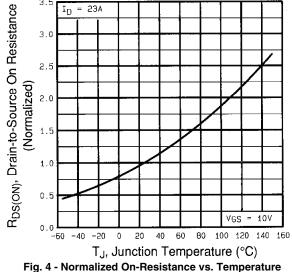


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



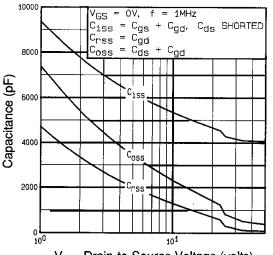






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V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

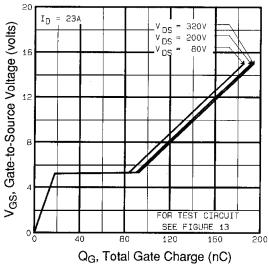


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

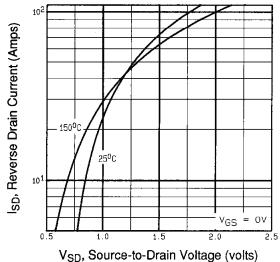
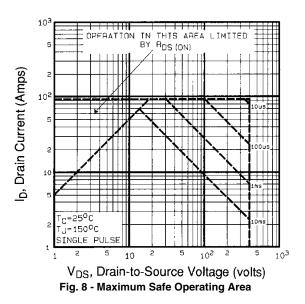


Fig. 7 - Typical Source-Drain Diode Forward Voltage



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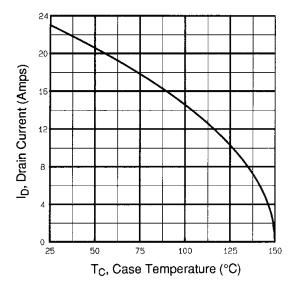


Fig. 9 - Maximum Drain Current vs. Case Temperature

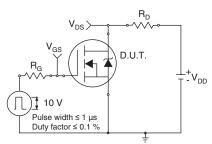


Fig. 10a - Switching Time Test Circuit

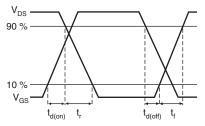
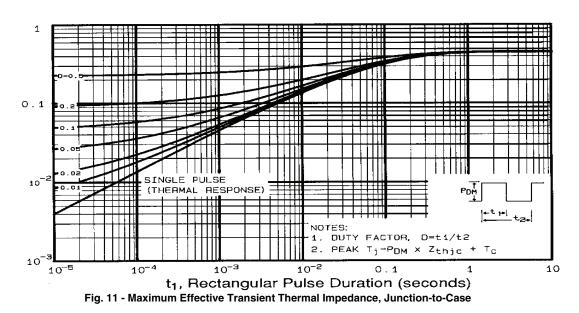
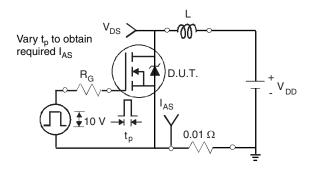
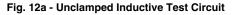


Fig. 10b - Switching Time Waveforms







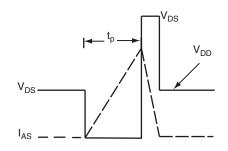
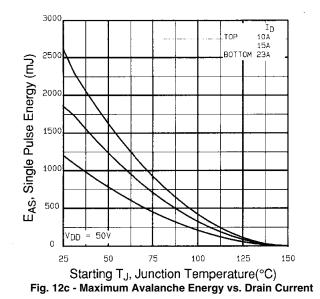
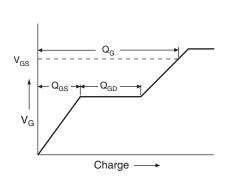


Fig. 12b - Unclamped Inductive Waveforms

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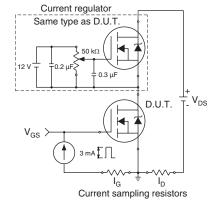
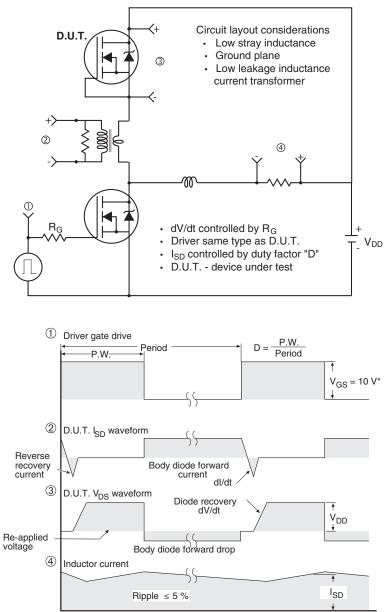


Fig. 13a - Basic Gate Charge Waveform

Fig. 13b - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel

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